

时间限制：C/C++/Rust/Pascal 8秒，其他语言16秒
空间限制：C/C++/Rust/Pascal 1024 M，其他语言2048 M
Special Judge, 64bit IO Format: %lld

题目描述

There is a grid with n rows and n columns ($3 \leq n \leq 200$). For $1 \leq i, j \leq n$, there is an undirected edge between the cell in the i -th row and j -th column and the cell in the i -th row and $(j + 1)$ -th column (the $(n + 1)$ -th column is considered as the 1-st column), with a weight of either 1 or 2. For $1 \leq i < n$ and $1 \leq j \leq n$, there is an undirected edge between the cell in the i -th row and j -th column and the cell in the $(i + 1)$ -th row and j -th column, also with a weight of either 1 or 2.

For $1 \leq i \leq n$, find the shortest path length from the cell in the 1-st row and i -th column to the cell in the n -th row and i -th column, passing through each column at least once.

输入描述:

The first line contains a positive integer T representing the number of test cases. The sum of n across all test cases does not exceed 200.

For each test case, the first line contains a positive integer n .

The next n lines each contain n integers, where the j -th integer of the i -th line represents the weight of the edge between the cell in the i -th row and j -th column and the cell in the i -th row and $(j + 1)$ -th column.

The following $n - 1$ lines each contain n integers, where the j -th integer of the i -th line represents the weight of the edge between the cell in the i -th row and j -th column and the cell in the $(i + 1)$ -th row and j -th column.

输出描述:

For each test, output a total of n lines, where the i -th line contains a single integer representing the shortest path length from the cell in the 1-st row and i -th column to the cell in the n -th row and i -th column, passing through each column at least once.

示例1

输入

2

复制

C++ (clang++18)

1

ACM模
请通过
入输出
出描述

运行结果 自测